

Vortex drag in a Thin-film Giaever transformer

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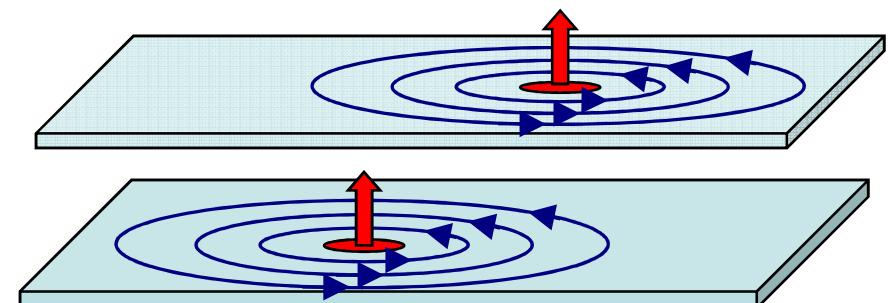
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Outline

- Experimental Motivation – SC-metal-insulator in InO, TiN, Ta and MoGe.
- Two paradigms:
 - Vortex condensation: Vortex metal theory.
 - Percolation paradigm
- Thin film Giaever transformer – amorphous thin-film bilayer.
- Predictions for the no-tunneling regime of a thin-film bilayer
- Conclusions

Quantum vortex physics

SC-insulator transition

- Thin films: B tunes a SC-Insulator transition.

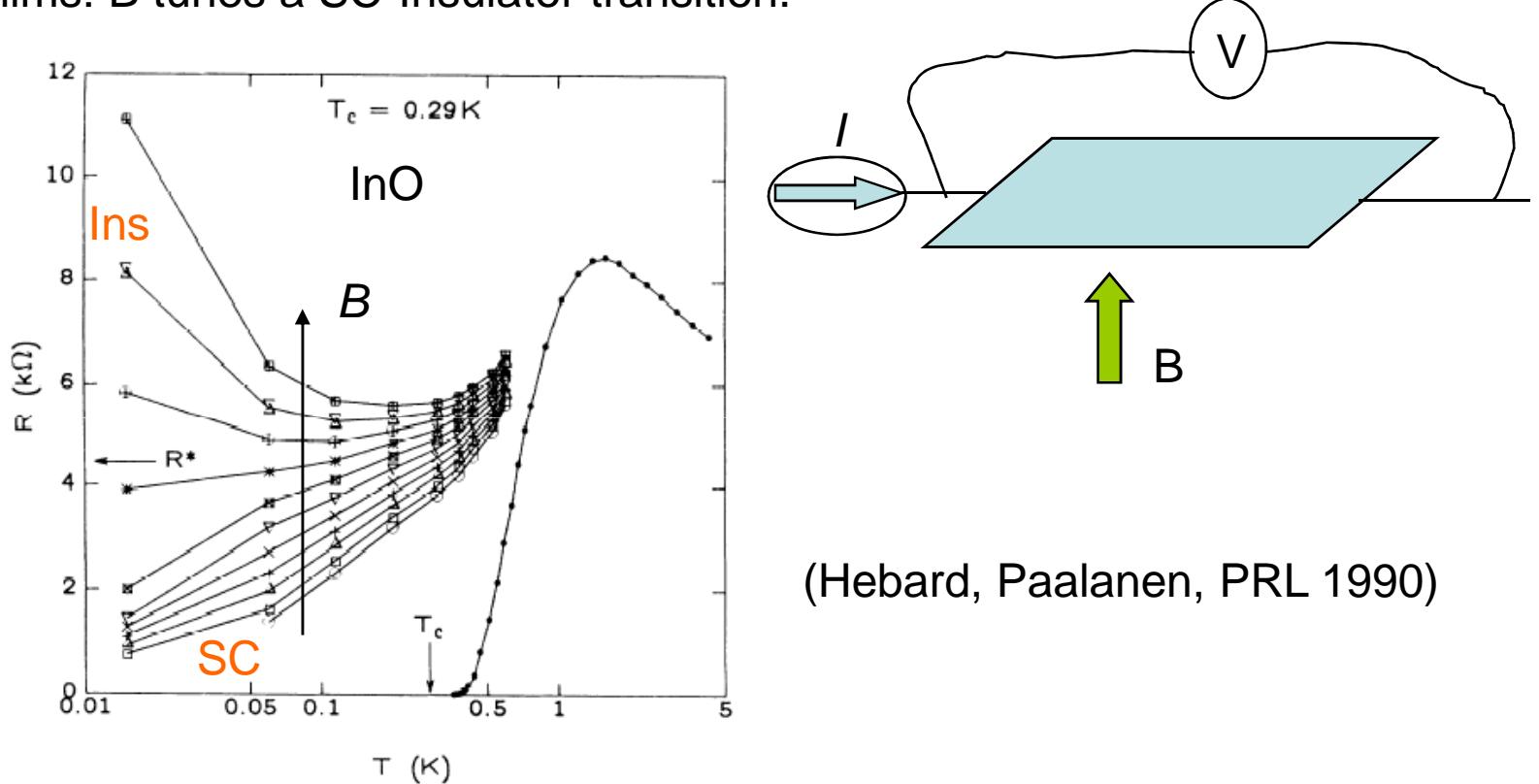
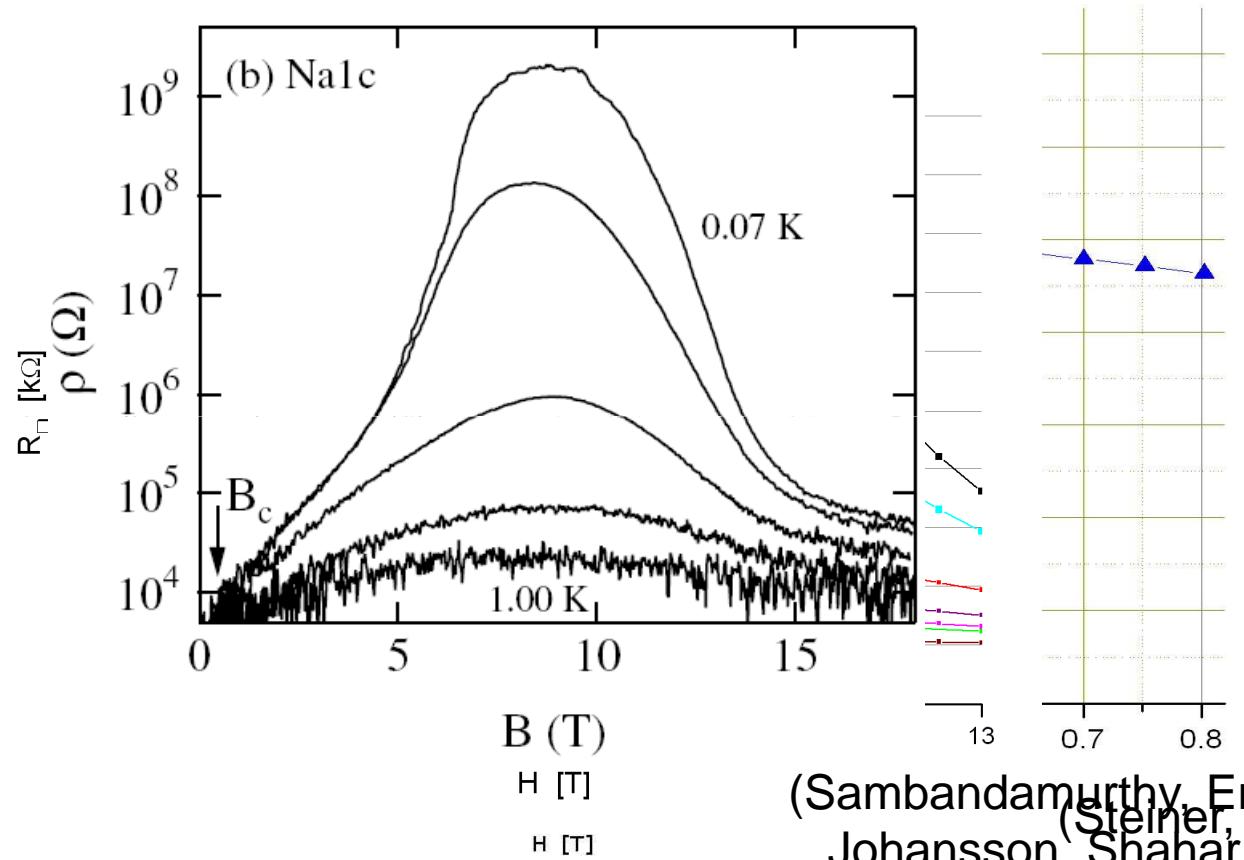


FIG. 1. Logarithmic plots of the resistance transitions in zero field (●) and nonzero field (open symbols) for a film with $T_c = 0.29$ K. The isomagnetic lines range from $B = 4$ kG (○) to $B = 6$ kG (□) in 0.2-kG steps. The horizontal and vertical arrows identify R^* and T_c , respectively.

Observation of Superconductor-insulator transition

- Thin amorphous films: B tunes a SC-Insulator transition.

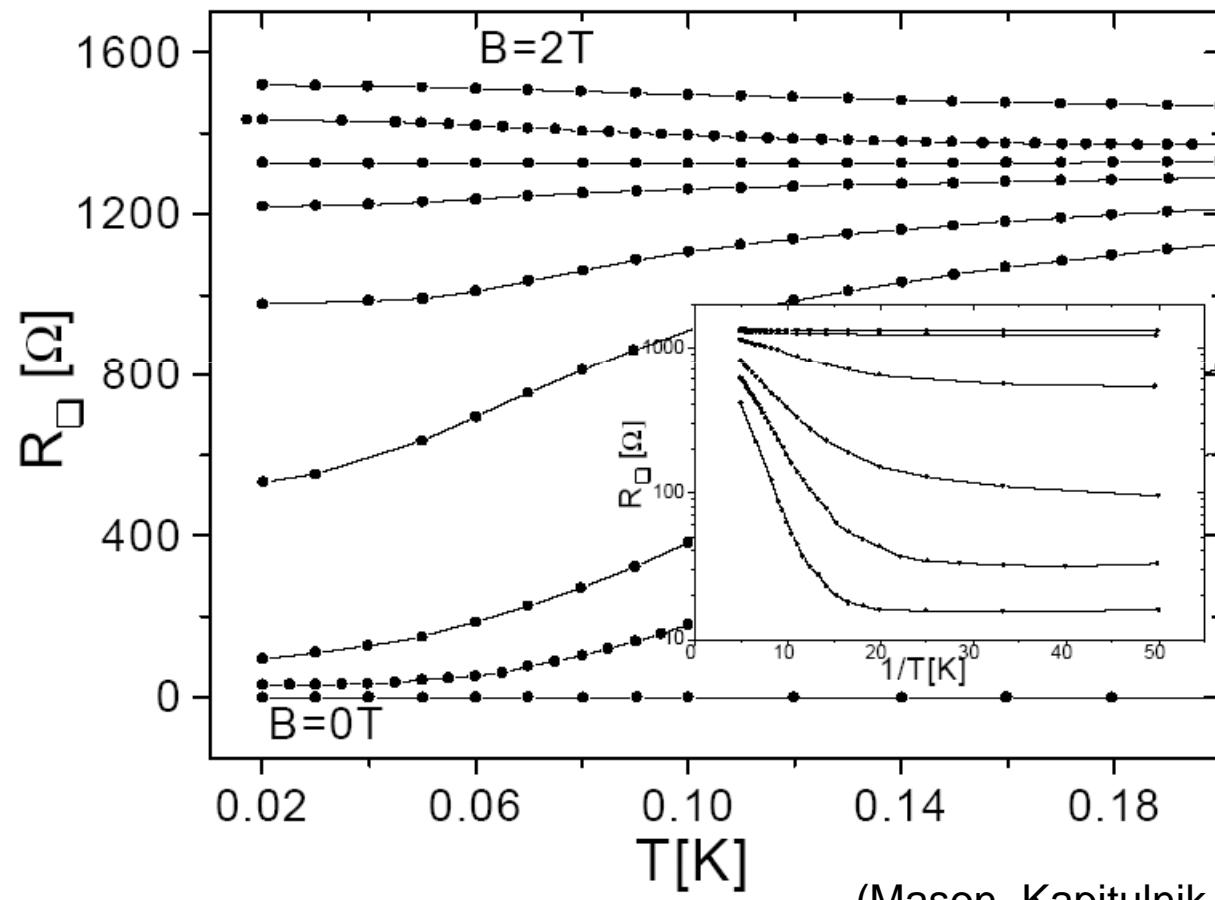
InO:



- Saturation as $T \rightarrow 0$
- Insulating peak different from sample to sample, scaling different – log, activated.

Observation of a metallic phase

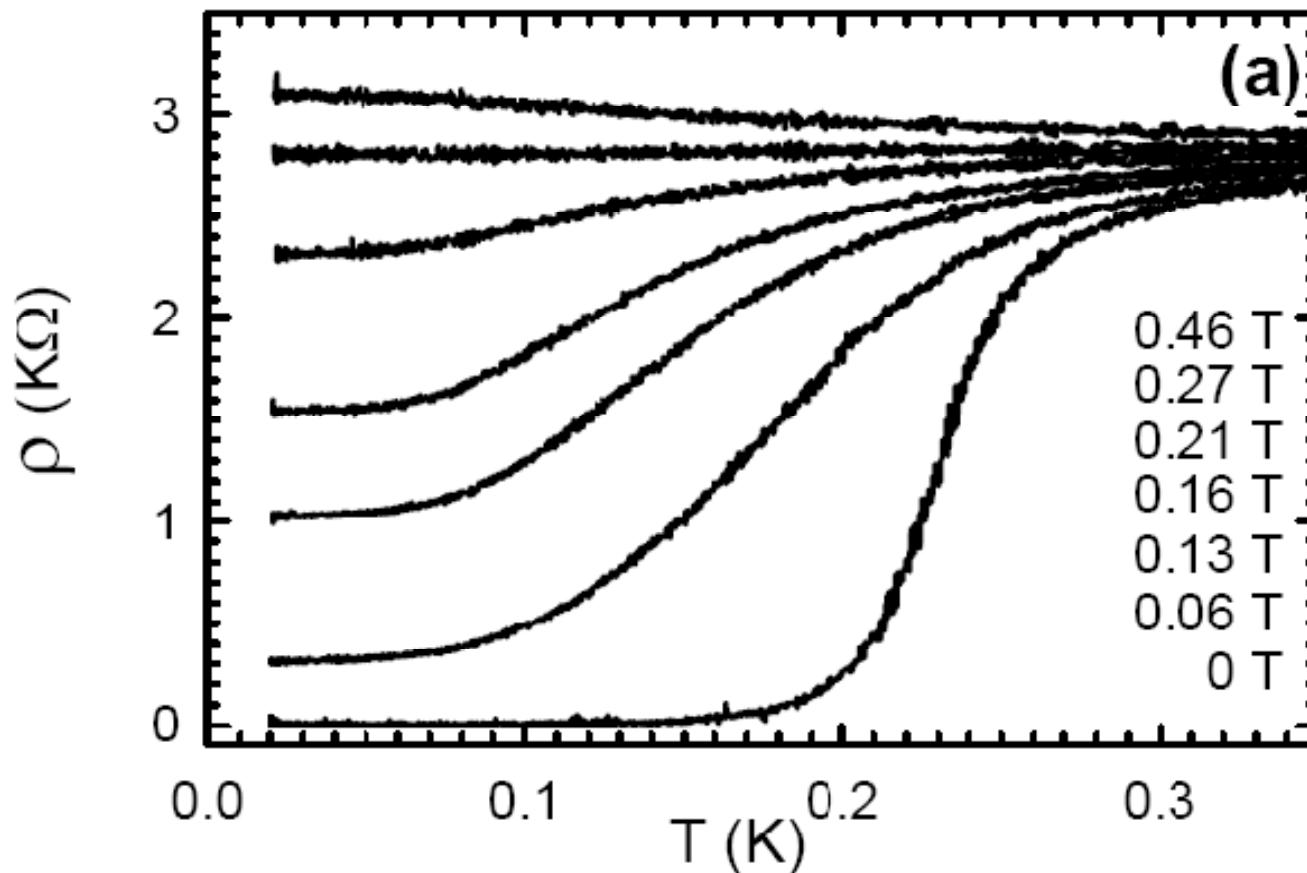
- MoGe:



(Mason, Kapitulnik, PRB 1999)

Observation of a metallic phase

- Ta:



(Qin, Vicente, Yoon, 2006)

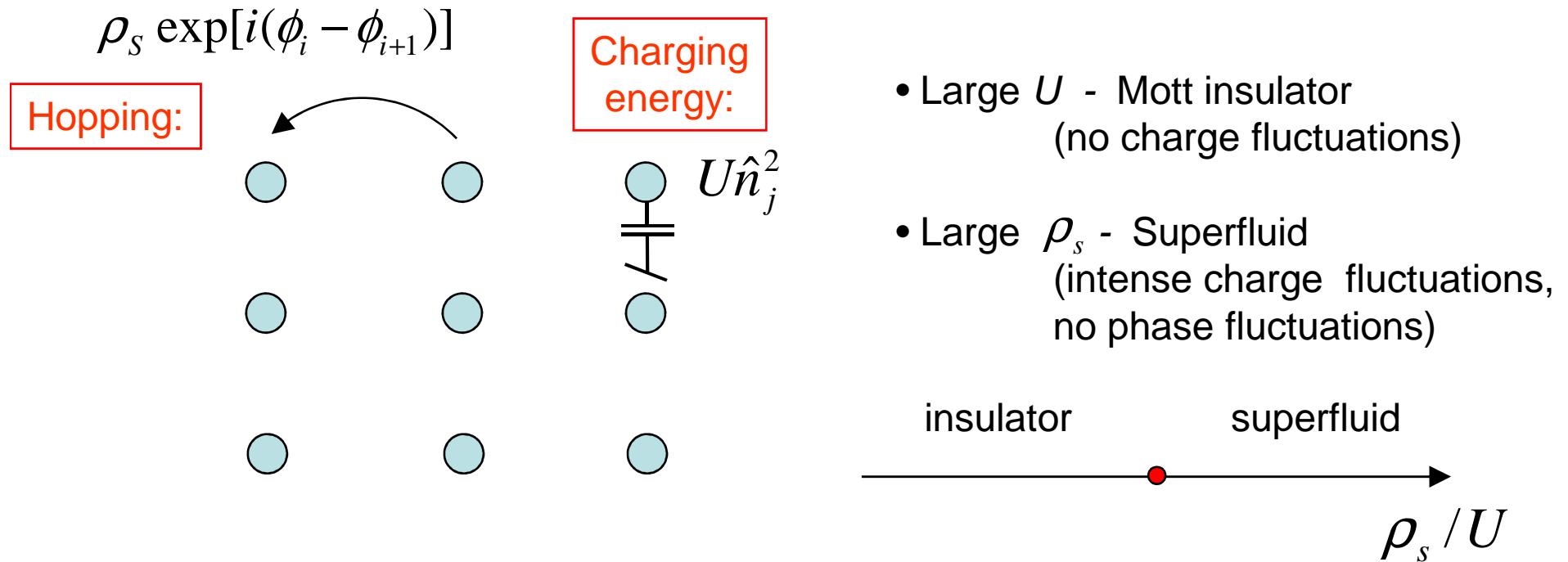
- Saturation at ~100mK: New metallic phase? (or saturation of electrons temperature)

Vortex Paradigm

X-Y model for superconducting film: Cooper pairs as Bosons

- When the superconducting order is strong – ignore electronic excitations.
- Standard model for bosonic SF-Ins transition – “Bose-Hubbard model”:

$$H = \sum_i \left\{ - \sum_j \rho_s \cos(\nabla_j \phi_i) + U \hat{n}_i^2 \right\} \quad [\hat{n}, \phi] = -i$$



Vortex description of the SF-insulator transition

(Fisher, 1990)

- Vortex hopping: (result of charging effects)

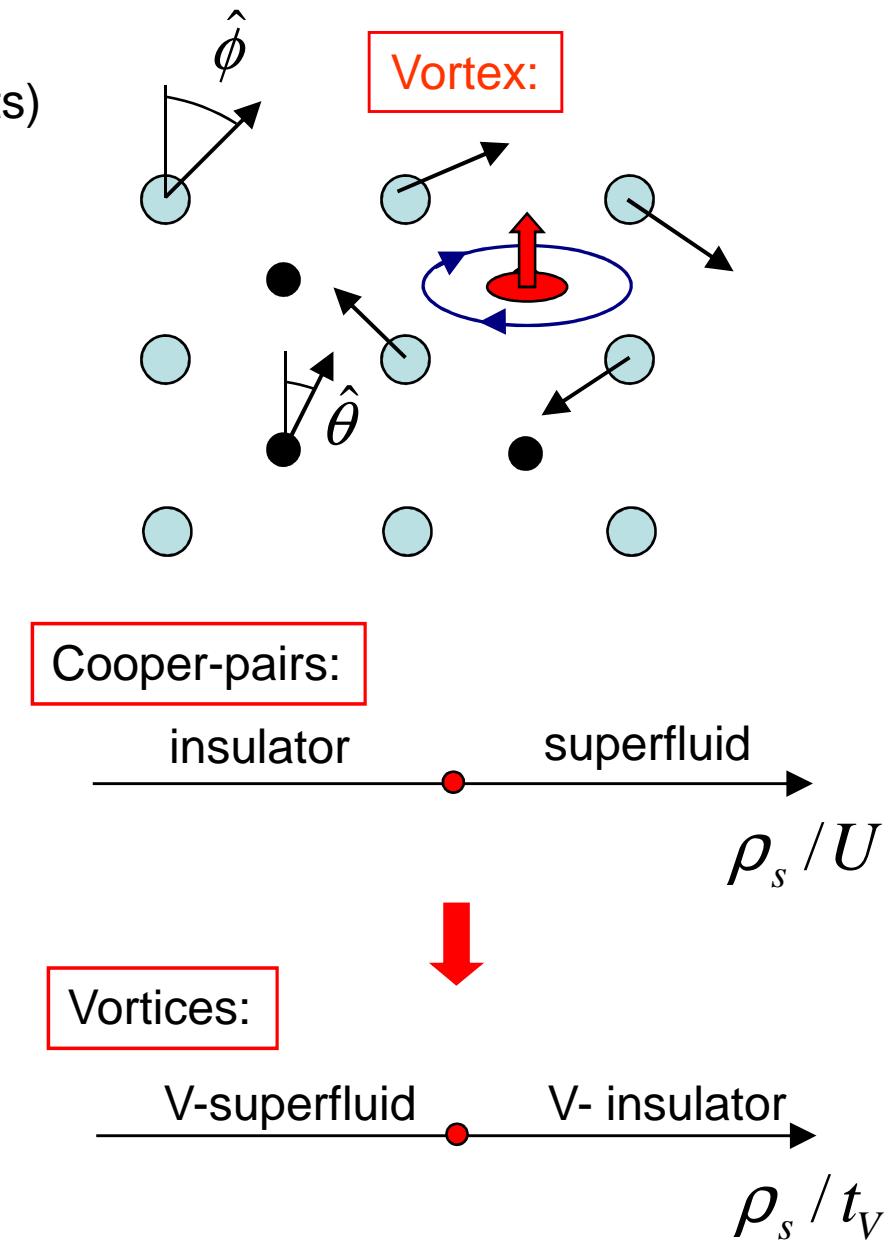
$$-t_V \cos(\nabla_j \hat{\theta}_i)$$

$$[\hat{n}_V, \theta] = -i$$

- Vortex-vortex interactions:

$$\frac{1}{2} \rho_s \sum_{i,j} n_{Vi} \cdot n_{Vj} \cdot \ln |\vec{x}_i - \vec{x}_j|$$

**Condensed vortices
= insulating CP's**



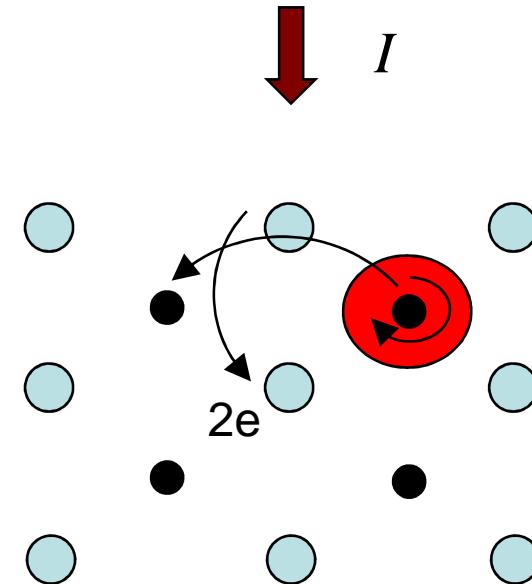
Universal (?) resistance at SF-insulator transition

Assume that vortices and Cooper-pairs are self dual at transition point.

- Current due to CP hopping: $I = \frac{2e}{\tau}$
- EMF due to vortex hopping:

$$\frac{\hbar}{2e} \dot{\Delta\phi} = \Delta V \quad \rightarrow \quad \Delta V = \frac{\hbar}{2e} \frac{2\pi}{\tau}$$

• Resistance: $R = \frac{V}{I} = \frac{2\pi\hbar}{2e\tau} / \frac{2e}{\tau} = \frac{\hbar}{4e^2} = 6.5k\Omega$



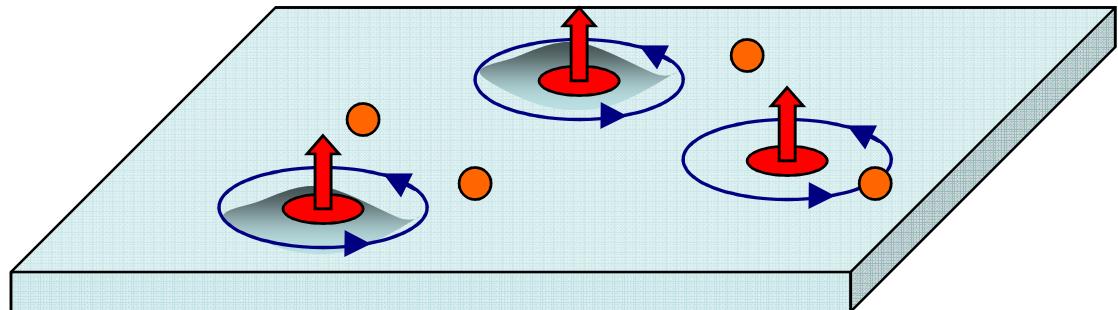
In reality superconducting films are not self dual:

- vortices interact logarithmically, Cooper-pairs interact at most with power law.
- Samples are very disordered and the disorder is different for cooper-pairs and vortices.

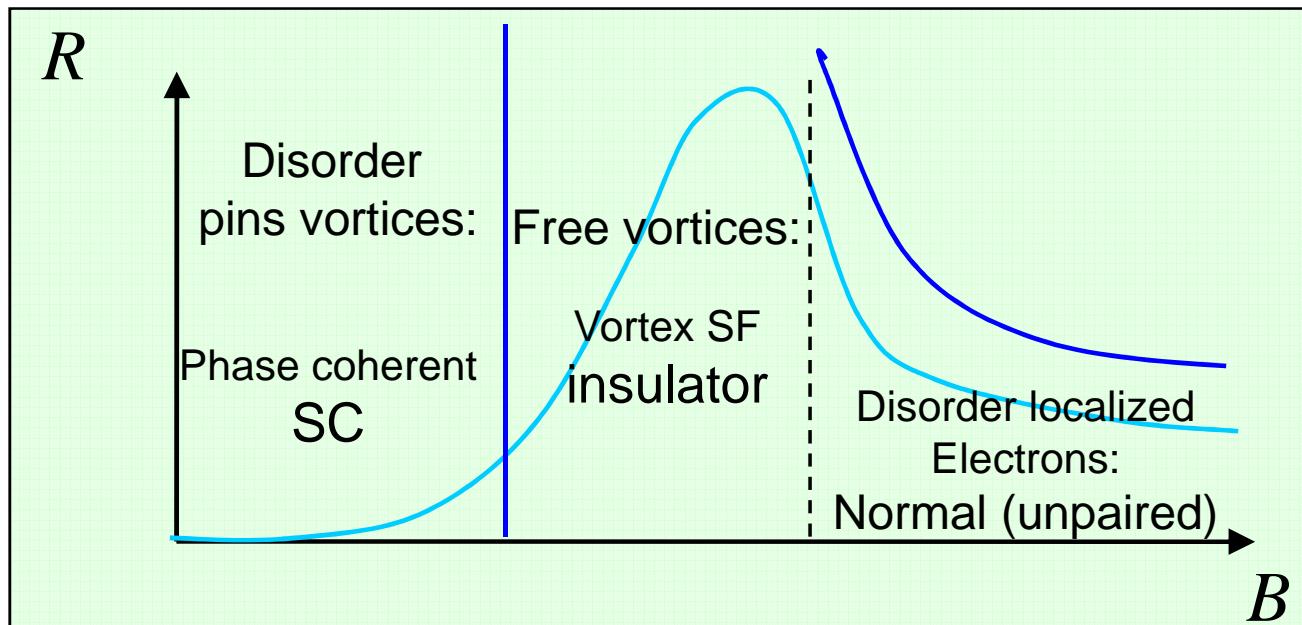
Magnetically tuned Superconductor-insulator transition

- Net vortex density:

$$\frac{\hbar}{2e} \langle \hat{n}_v \rangle = B$$



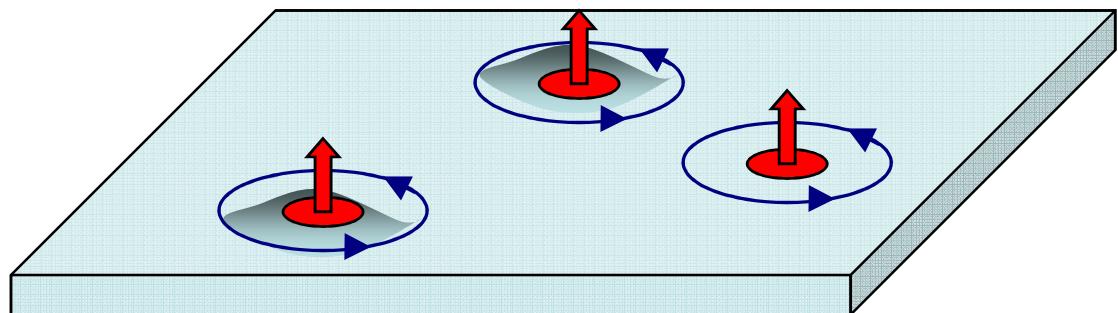
- Disorder pins vortices for small field – **superconducting phase**.
- Large fields some free vortices appear and condense – **insulating phase**.
- Larger fields superconductivity is destroyed – **normal (unpaired) phase**.



Magnetically tuned Superconductor-insulator transition

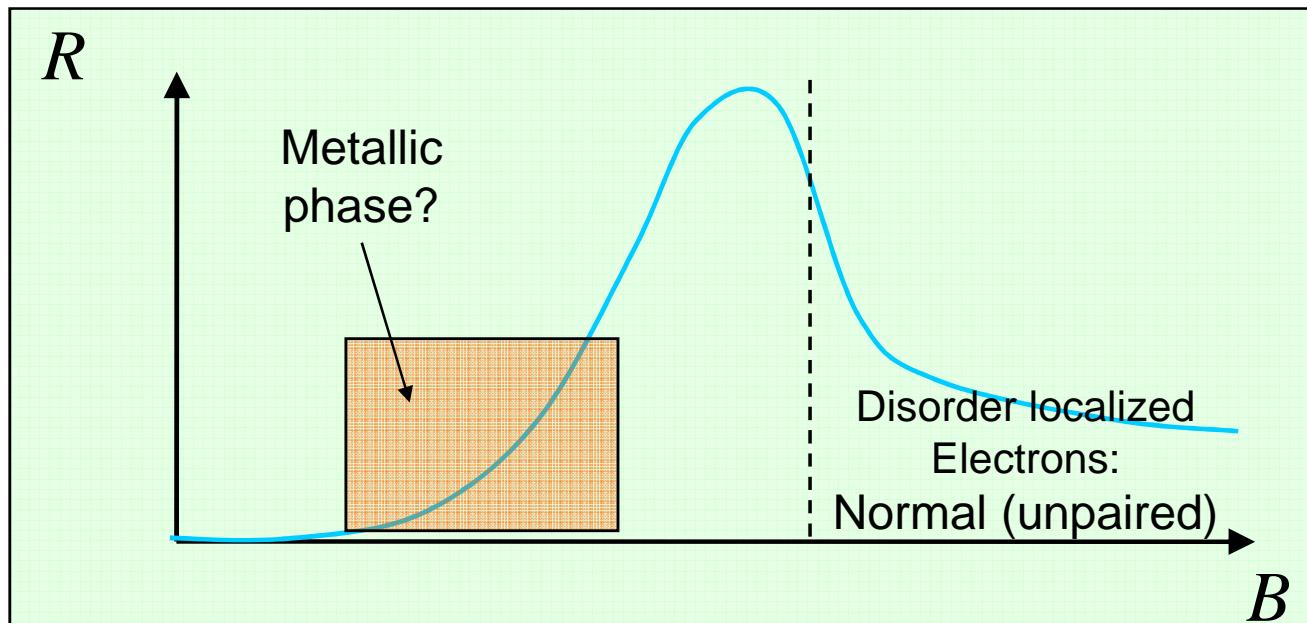
- Net vortex density:

$$\frac{h}{2e} \langle \hat{n}_v \rangle = B$$



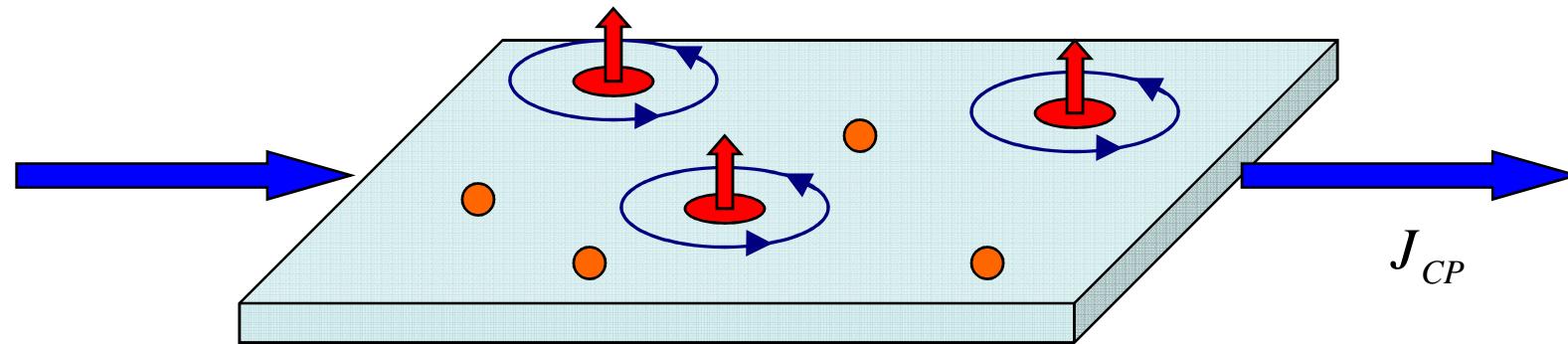
Problems

- Saturation of the resistance – ‘metallic phase’
- Non-universal insulating peak – completely different depending on disorder.

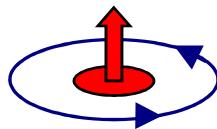


Two-fluid model for the SC-Metal-Insulator transition

(Galitski, Refael, Fisher, Senthil, 2005)



**Uncondensed vortices:
Cooper-pair channel**



Finite conductivity:

$$\vec{j}_V = \sigma_V \vec{F}_V = -\sigma_V (\hat{z} \times \vec{J}_{CP})$$

$$\vec{E} = \hat{z} \times \vec{j}_V \implies \boxed{\vec{J}_{CP} = \frac{1}{\sigma_V} \vec{E}}$$

**Disorder induced Gapless QP's
(electron channel)**
(delocalized core states?)

$$\boxed{\vec{j}_e = \sigma_e \vec{E}}$$

Two channels in parallel:

$$\boxed{\vec{J}_{CP} = (\sigma_e + \sigma_V^{-1}) \vec{E}}$$

Transport properties of the vortex-metal

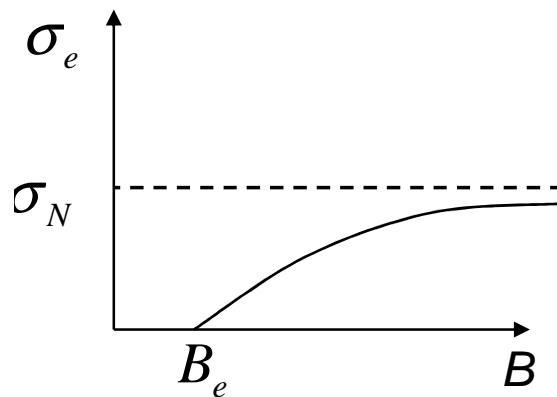
Effective conductivity:

$$\sigma_{eff} = \sigma_e + \sigma_V^{-1}$$

- Assume:

- σ_e grows from zero to σ_N .

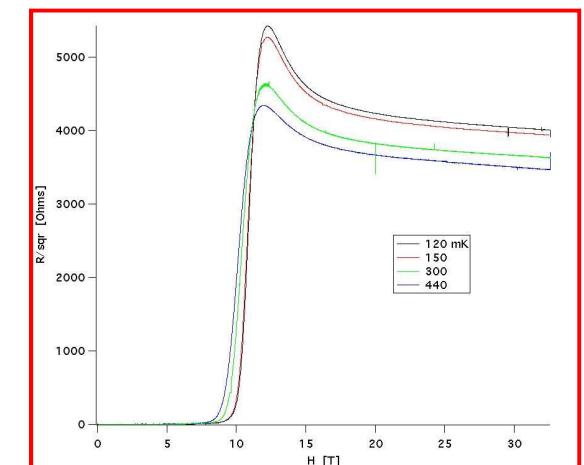
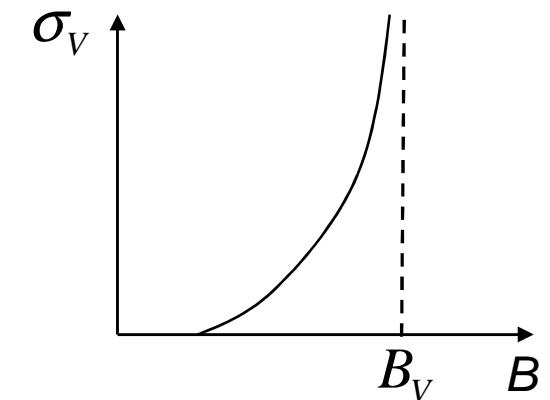
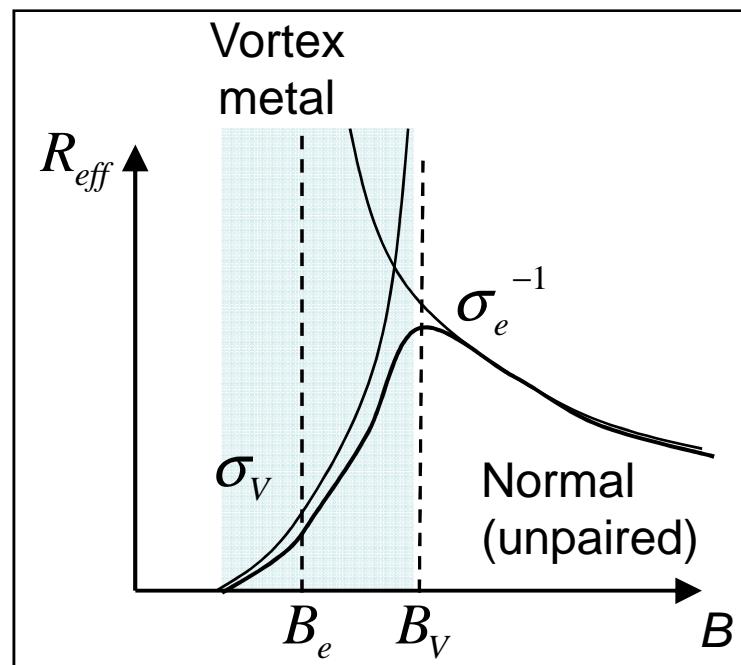
- σ_V grows from zero to infinity.



Weak insulators:

Ta, MoGe
Weak InO

$$B_e < B_V$$



Transport properties of the vortex-metal

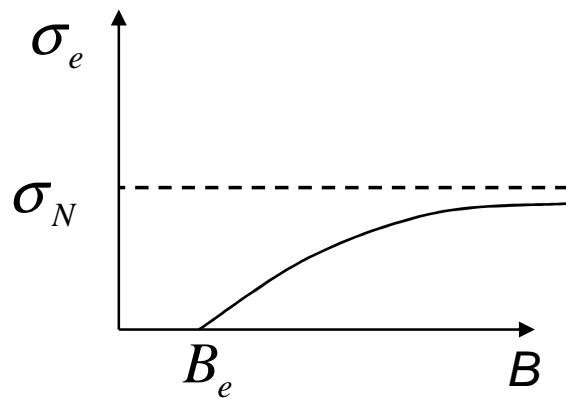
Effective conductivity:

$$\sigma_{eff} = \sigma_e + \sigma_V^{-1}$$

Chargless spinons contribute to conductivity!

- Assume:

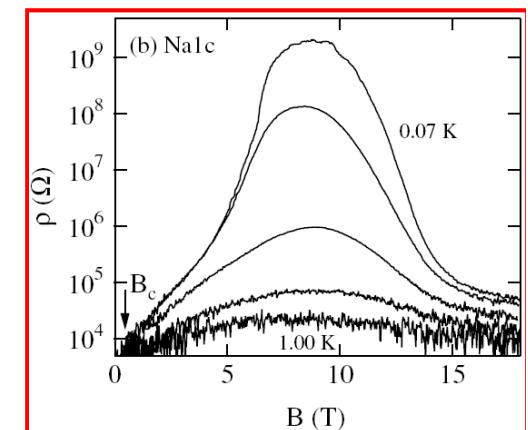
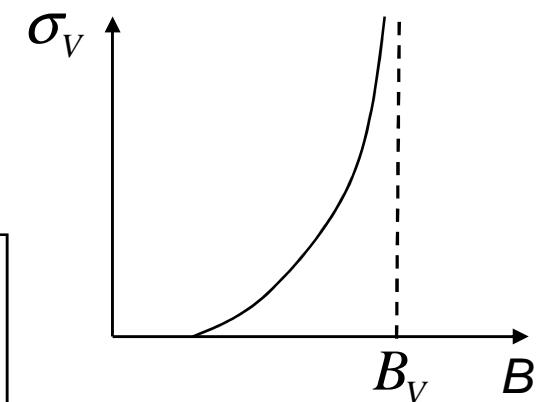
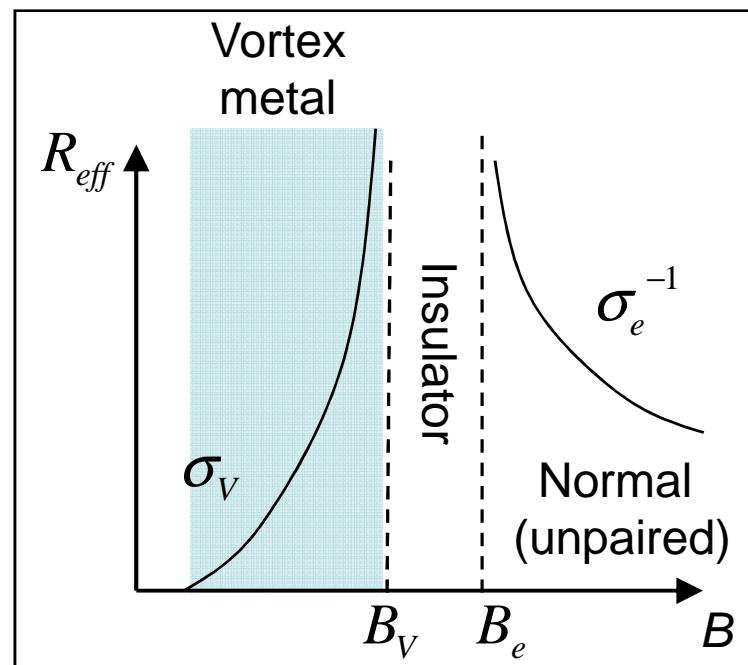
- σ_e grows from zero to σ_N .
- σ_V grows from zero to infinity.



Strong insulators:

TiN, InO

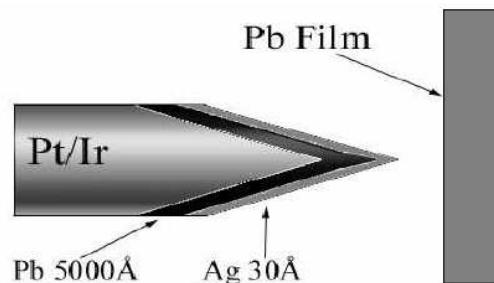
$$B_e > B_V$$



More physical properties of the vortex metal *Cooper pair tunneling*

- A superconducting STM can tunnel Cooper pairs to the film:

$$G = G_{2e} + G_{CP}$$



(Naaman, Tyzer, Dynes, 2001).

More physical properties of the vortex metal

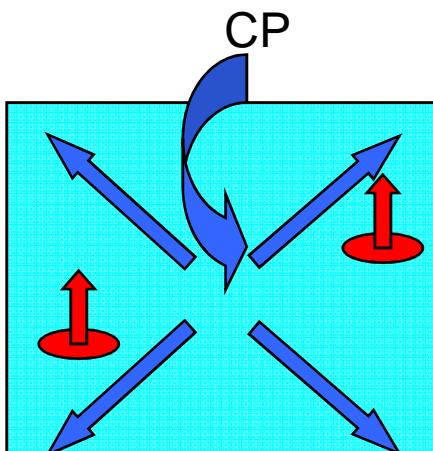
Cooper pair tunneling

- A superconducting STM can tunnel Cooper pairs to the film:

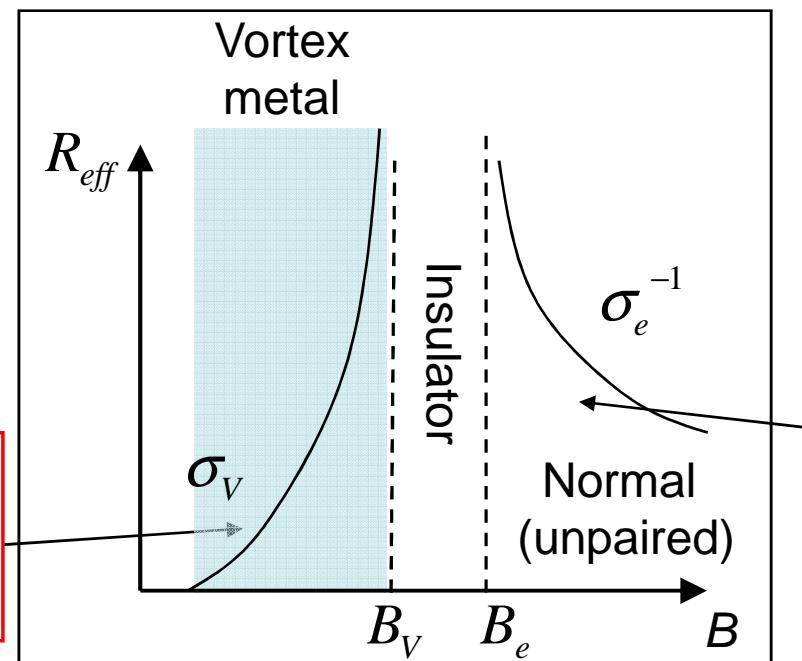
$$G = G_{2e} + G_{CP}$$

Vortex metal phase:

$$G_{CP} \sim \frac{1}{T^2} \exp(-\sigma_V \ln^2 T)$$

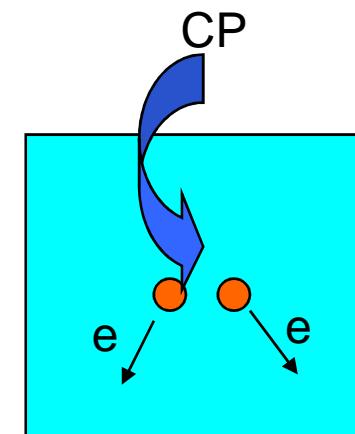


$G \approx G_{CP}$
strongly T dependent



Normal phase:

$$G_{2e} \sim \sigma_e^2$$



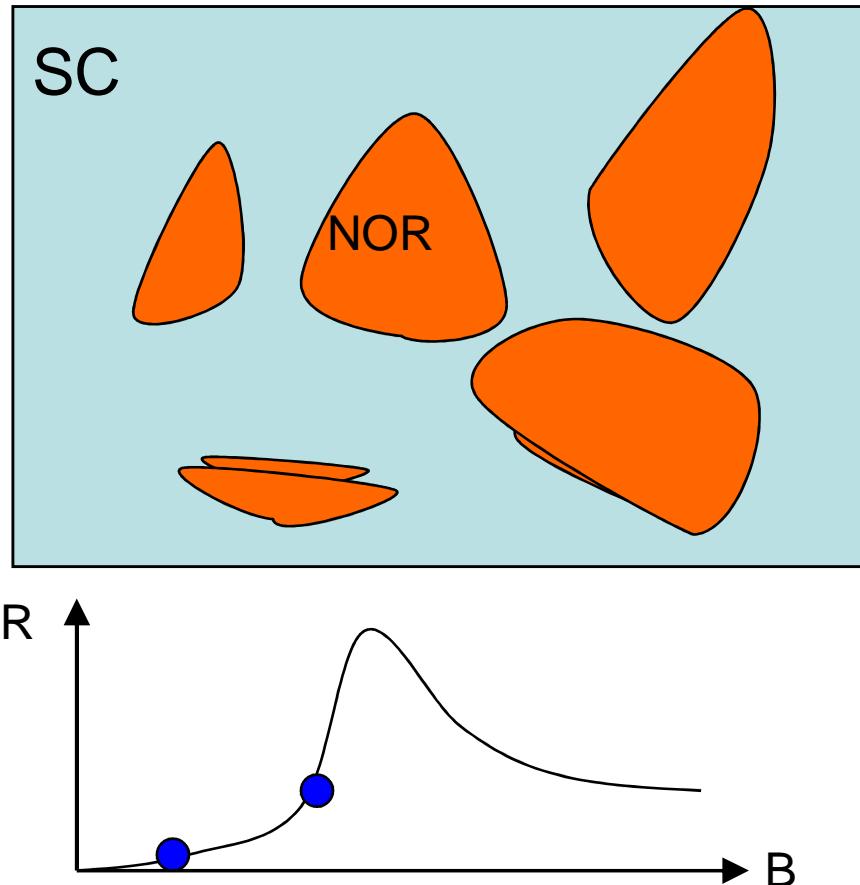
$G \approx G_{2e}$
 $\sim 1/\ln^2 T$

Percolation Paradigm

(Trivedi,
Dubi, Meir, Avishai,
Spivak, Kivelson,
et al.)

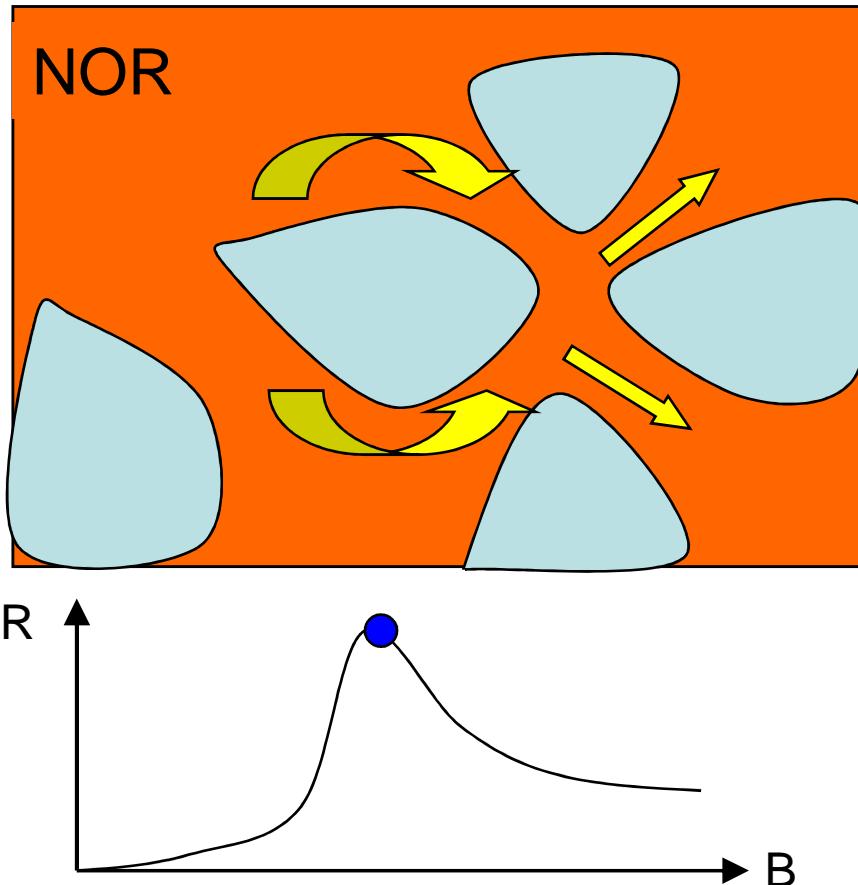
Pardigm II: superconducting vs. Normal regions percolation

- Strong disorder breaks the film into superconducting and normal regions.



Pardigm II: superconducting vs. Normal regions percolation

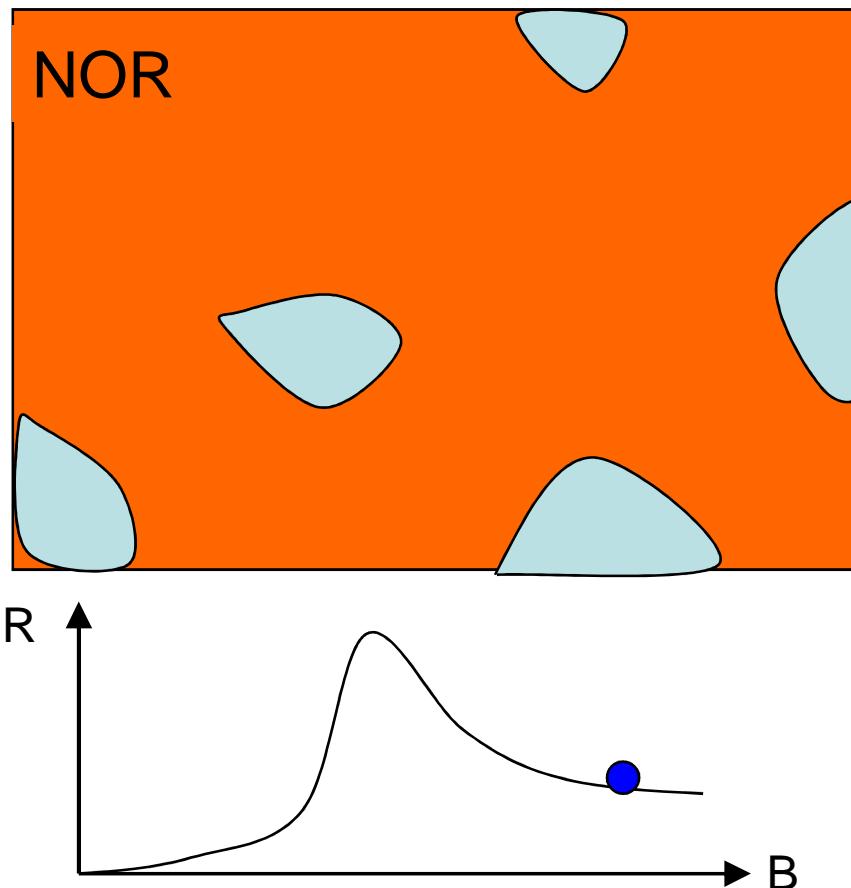
- Strong disorder breaks the film into superconducting and normal regions.



- Near percolation – thin channels of the disorder-localized normal phase.

Pardigm II: superconducting vs. Normal regions percolation

- Strong disorder breaks the film into superconducting and normal regions.

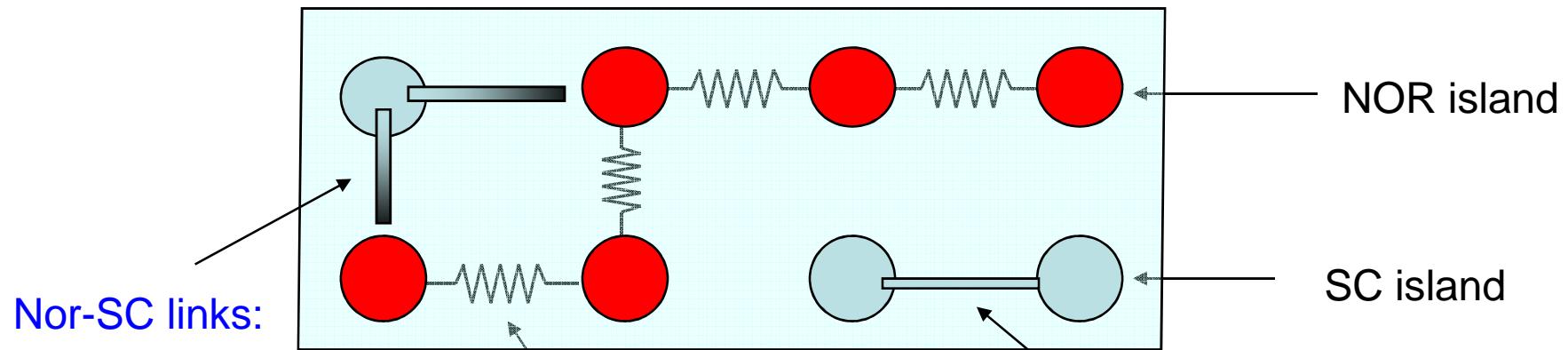


- Near percolation – thin channels of the disorder-localized normal phase.
- Far from percolation – disordered localized normal electrons.

Magneto-resistance curves in the percolation picture

(Dubi, Meir, Avishai, 2006)

- Simulate film as a resistor network:



$$R \sim R_0 e^{E_G/T}$$

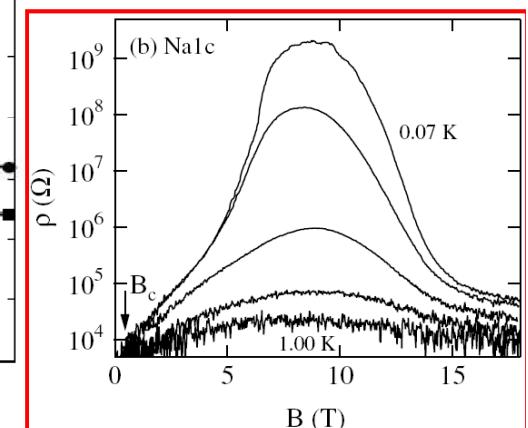
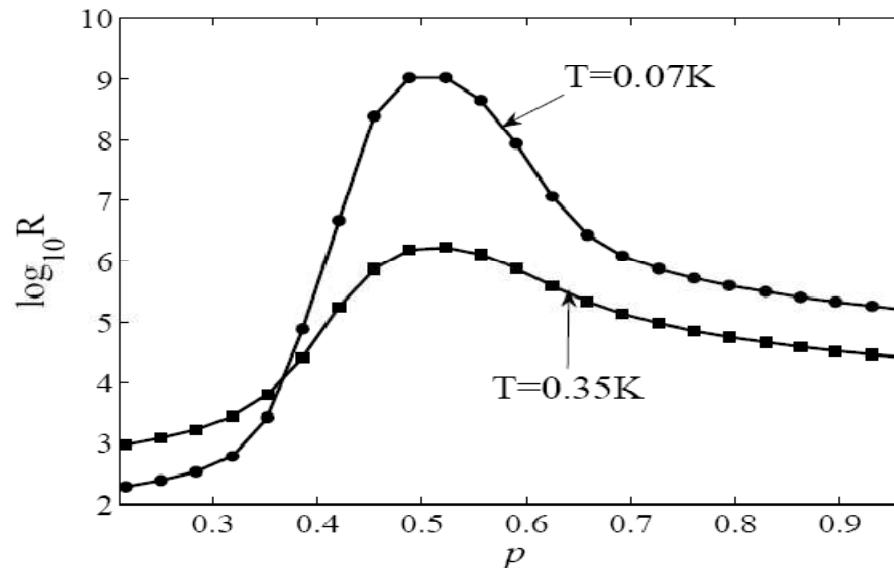
Normal links:

$$R \sim R_0 e^{(|\varepsilon_1| + |\varepsilon_2| + |\varepsilon_1 - \varepsilon_2|)/kT}$$

SC-SC links:

$$R \sim T^\alpha$$

Resulting MR:



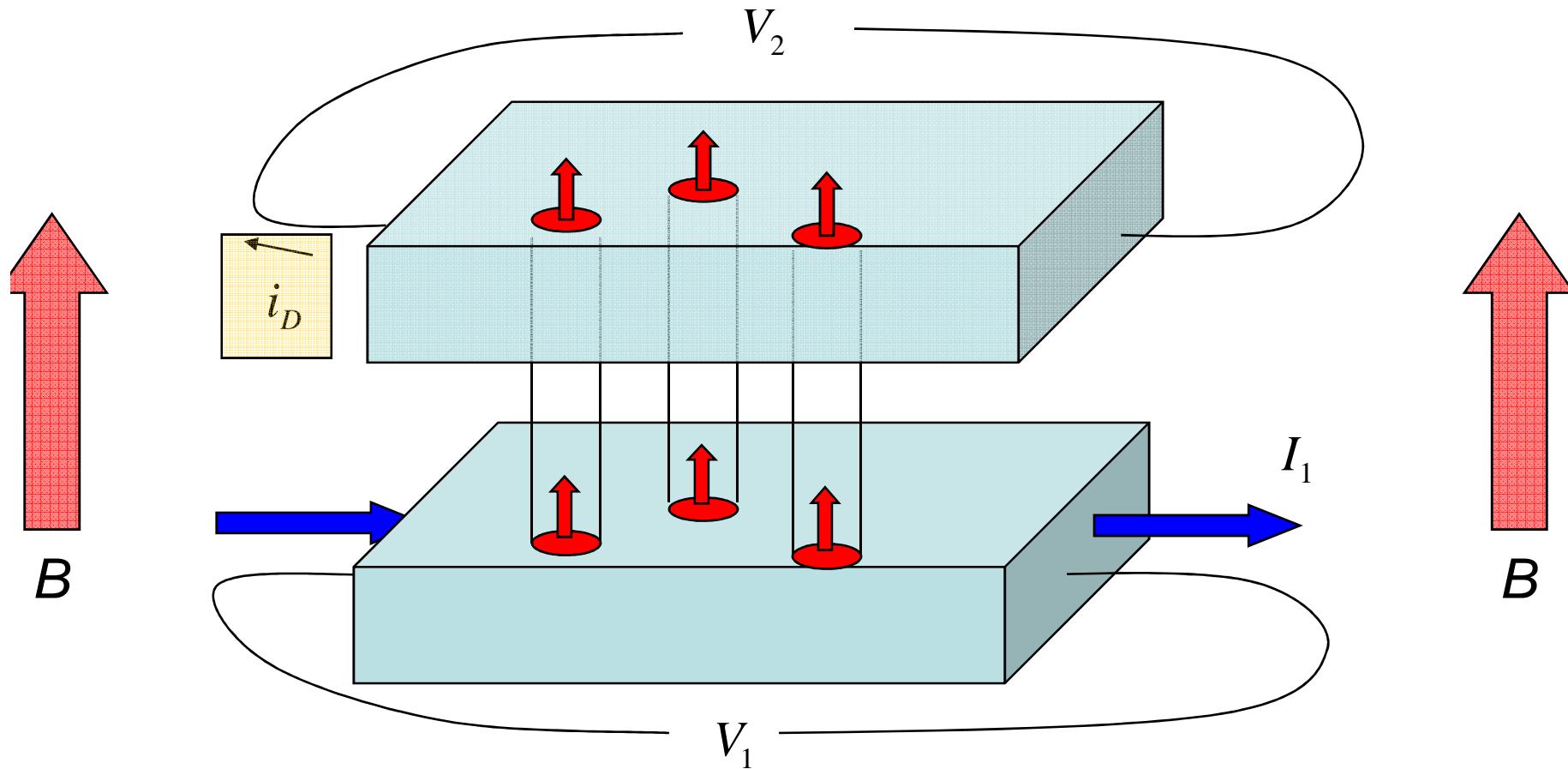
Drag in a bilayer system

Giaever transformer – Vortex drag

(Giaever, 1965)

Two type-II bulk superconductors:

$$R_D = \frac{V_2}{I_1}$$



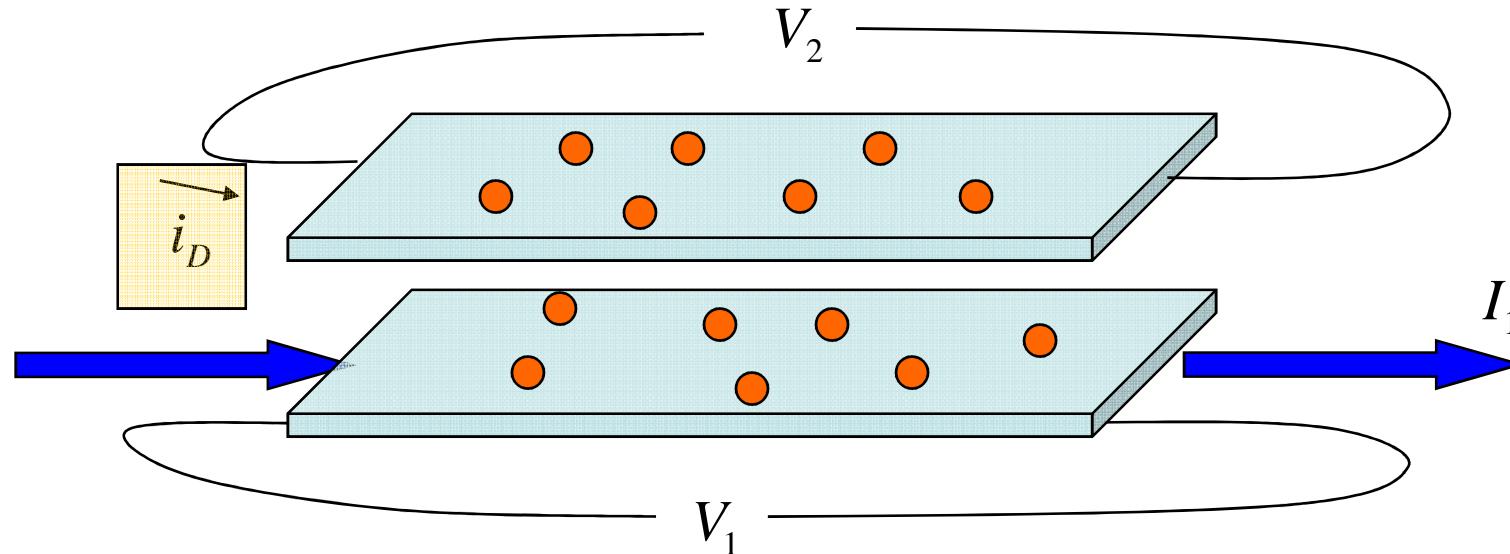
Vortices tightly bound:

$$V_2 = V_1 \quad \longrightarrow \quad R_D = \frac{V_1}{I_1} = R_1$$

2DEG bilayers – Coulomb drag

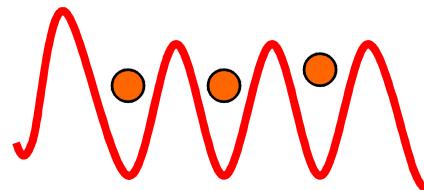
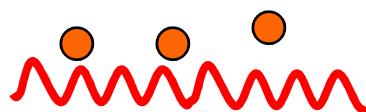
Two thin electron gases:

$$R_D = \frac{V_2}{I_1}$$



- Coulomb force creates friction between the layers.
- Inversely proportional to density squared:
- Opposite sign to Giaever's vortex drag.

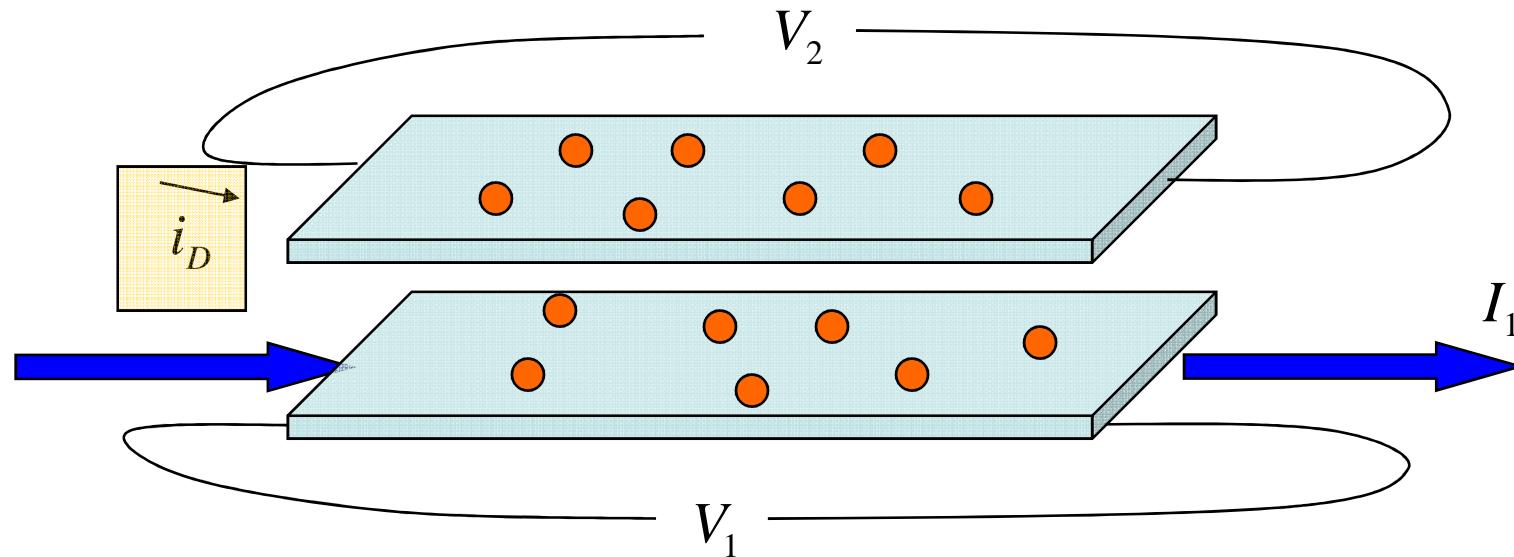
$$R_D \propto \frac{1}{n_e^2}$$



2DEG bilayers – Coulomb drag

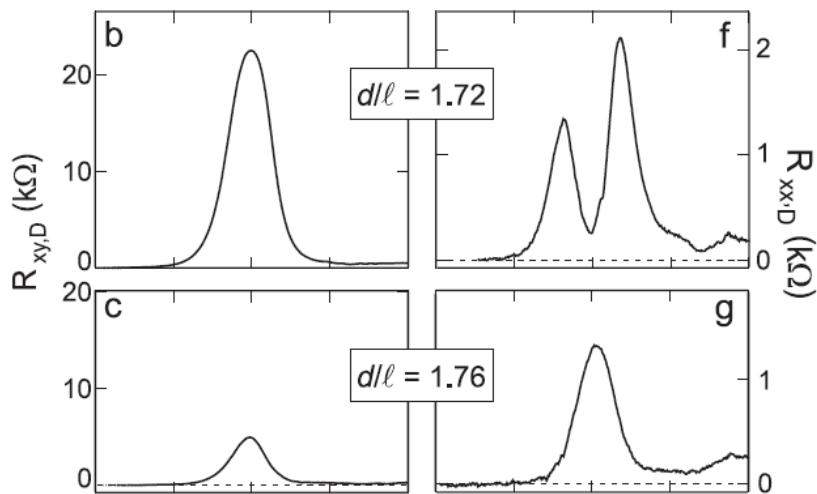
Two thin electron gases:

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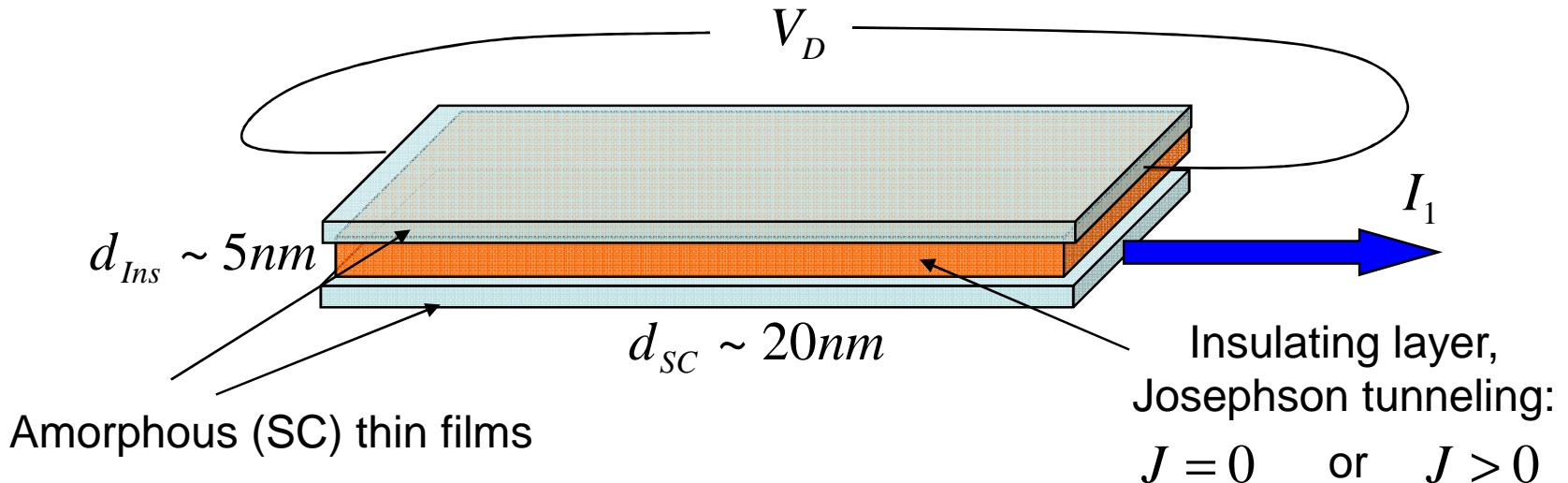
Example:

$\nu_T = 1$ “Excitonic condensate”



(Kellogg, Eisenstein, Pfeiffer, West, 2002)

Thin film Giaever transformer



Percolation paradigm

- Drag is due to coulomb interaction.
- Electron density:

$$n_{2d} \sim d_{SC} \cdot 10^{20} \text{ cm}^{-3} \rightarrow 2 \cdot 10^{14} \text{ cm}^{-2}$$

(QH bilayers: $n_{2d} \sim 5 \cdot 10^{10} \text{ cm}^{-2}$)

Drag suppressed

Vortex condensation paradigm

- Drag is due to inductive current interactions, and Josephson coupling.
- Vortex density:

$$n_V \sim \frac{B}{\phi_0} \sim (10^{11} \cdot B_{[T]}) \text{ cm}^{-2}$$

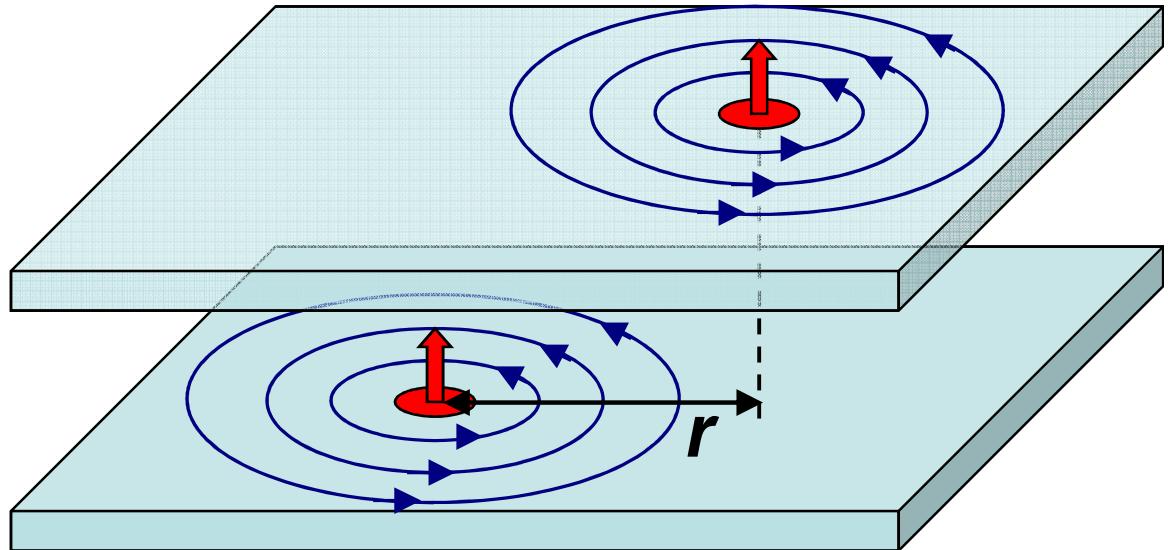
Significant Drag

Vortex drag in thin films bilayers: interlayer interaction

- Vortex current suppressed.

e.g., Pearl penetration length:

$$\lambda_{eff} = \frac{2\lambda_L^2}{d_{SC}}$$

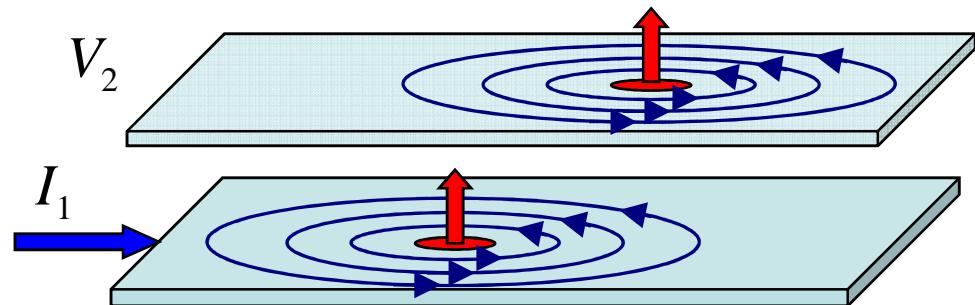


- Vortex attraction=interlayer induction.
Also suppressed due to thinness.

$$U_{\text{inter}}(q) \approx \frac{\phi_0^2}{2\pi\lambda_{\text{eff}}^2} \frac{e^{-qa}}{q[(q + \lambda_{\text{eff}}^{-1})^2 - e^{-2qa}/\lambda_{\text{eff}}^2]} \sim \begin{cases} \frac{\phi_0^2}{4\pi\lambda_{\text{eff}}} \ln(r), & r > \lambda_{\text{eff}} \\ \frac{\phi_0^2}{4\lambda_{\text{eff}}^2} \frac{r^2}{a}, & r < a \end{cases}$$

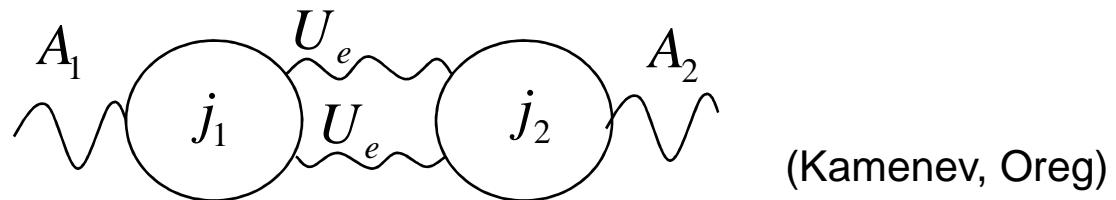
Vortex drag in thin films within vortex metal theory

- $R_D = \frac{V_2}{I_1}$



- Perturbatively:

$$R_D = G_V^{\text{drag}} \sim [j_1, j_2]$$



- Expect: $G_V^{\text{drag}} \propto \frac{\partial \sigma_{V1} \sigma \partial \sigma_{V2}}{\partial n_{V1} n_{V2} \partial n_{V2}} \rightarrow \boxed{\propto \frac{\partial R_1}{\partial B} \cdot \frac{\partial R_2}{\partial B}}$ Drag generically proportional to MR slope.

(Following von Oppen, Simon, Stern, PRL 2001)

- Answer:

$$R_D = G_V^{\text{drag}} = \frac{e^2 \phi_0^2}{8\pi^4 T} \frac{\partial R_1}{\partial B} \frac{\partial R_2}{\partial B} \int d\omega \int dq q^3 |U|^2 \frac{\text{Im } \chi_1 \text{ Im } \chi_2}{\sinh^2(\omega/2T)}$$

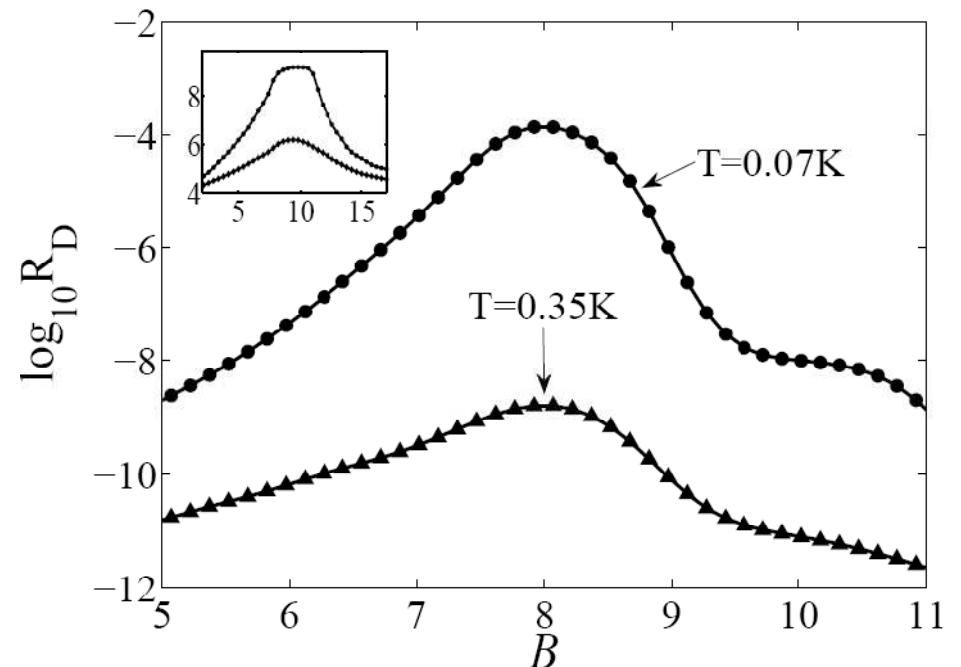
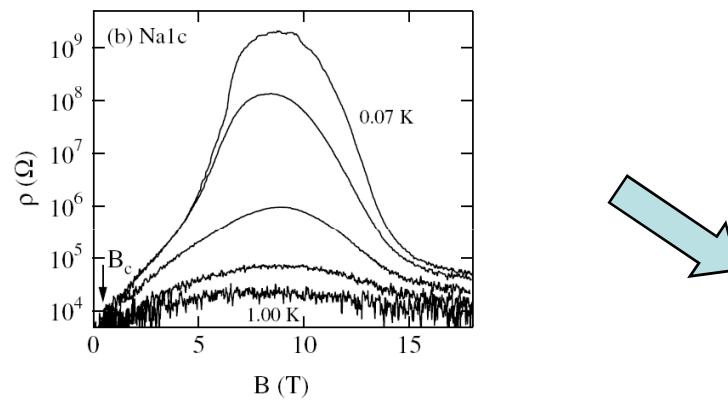
U – screened inter-layer potential.

χ - Density response function (diffusive FL)

Vortex drag in thin films: Results

$$R_D = G_V^{drag} = \frac{e^2 \phi_0^2}{8\pi^4 T} \frac{\partial R_1}{\partial B} \frac{\partial R_2}{\partial B} \int d\omega \int dq q^3 |U|^2 \frac{\text{Im } \chi_1 \text{ Im } \chi_2}{\sinh^2(\omega/2T)}$$

- Our best chance (with no J tunneling) is the highly insulating InO:



- maximum drag:

$$R_D^{\max} \sim 0.1 m\Omega$$

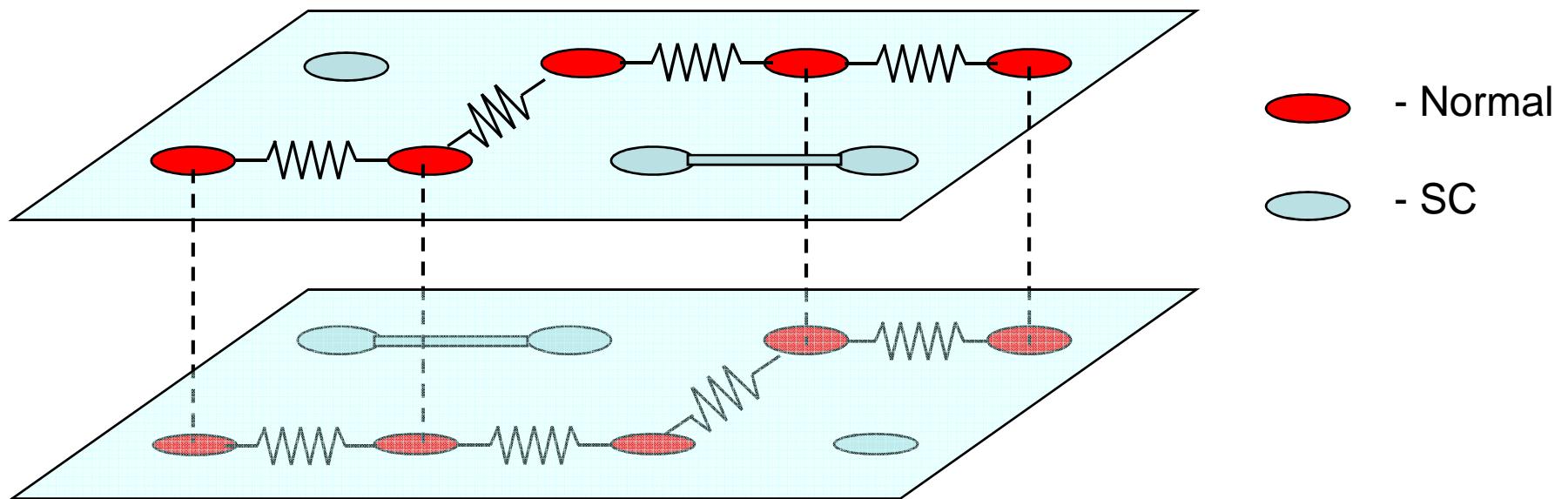
Note: similar analysis for SC-metal ‘bilayer’ using a ground plane.

Experiment: Mason, Kapitulnik (2001)

Theory: Michaeli, Finkel’stein, (2006)

Percolation picture: Coulomb drag

- Solve a 2-layer resistor network with drag.



- Can neglect drag with the SC islands:

$$R_{SC-SC}^D, R_{SC-NOR}^D \approx 0$$

- Normal-Normal drag – use results for disorder localized electron glass:

$$R_{NOR-NOR}^D = \frac{1}{96\pi^2} \frac{R_1 R_2}{\hbar/e^2} \frac{T^2}{(e^2 n_e a d_{film})^2} \ln \frac{1}{2x_0}$$

(Shimshoni, PRL 1987)

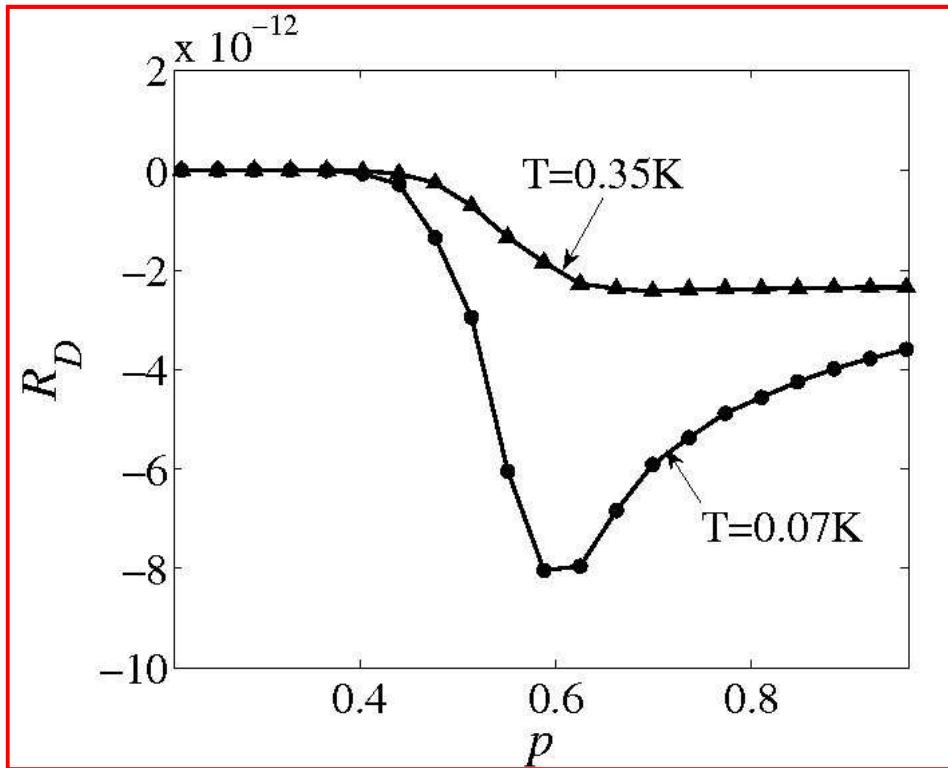
Percolation picture: Results

- Drag resistances:

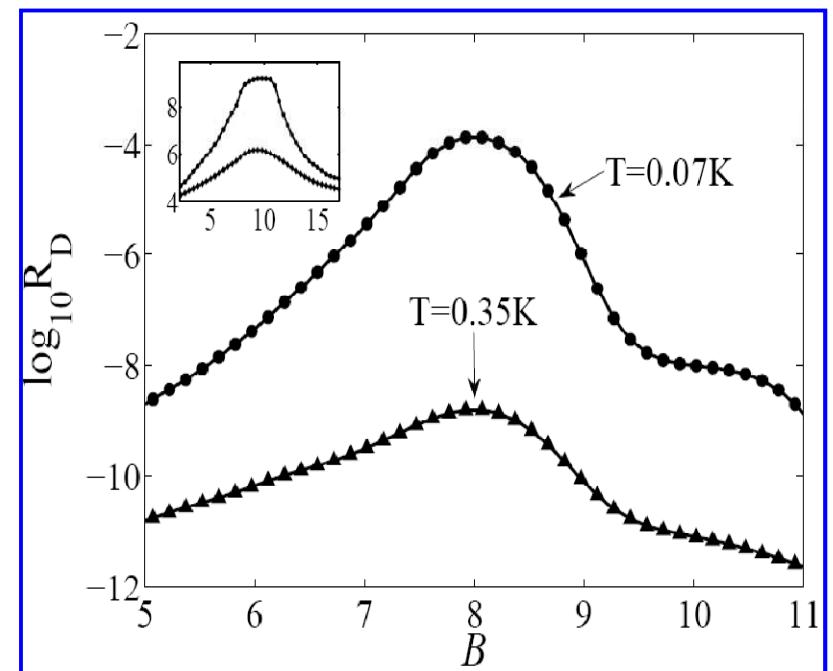
$$R_{SC-SC}^D, R_{SC-NOR}^D \approx 0$$

$$R_{NOR-NOR}^D = \frac{1}{96\pi^2} \frac{R_1 R_2}{\hbar/e^2} \frac{T^2}{(e^2 n_e a d_{film})^2} \ln \frac{1}{2x_0}$$

- Solution of the random resistor network:



Compare to vortex drag:



Conclusions

- Vortex picture and the puddle picture: similar single layer predictions.
- Giaever transformer bilayer geometry may qualitatively distinguish:
Large drag for vortices, small drag for electrons, with opposite signs.
- Drag in the limit of zero interlayer tunneling:

$R_D^{vortex} \sim 0.1m\Omega$ vs. $R_D^{percolation} \sim 10^{-11}\Omega$
- Intelayer Josephson should increase both values, and enhance the effect.
(future theoretical work)
- Amorphous thin-film bilayers will yield interesting complementary information about the SIT.

Conclusions

- What induces the gigantic resistance and the SC-insulating transition?
- What is the nature of the insulating state? Exotic vortex physics?

Phenomenology:

- Vortex picture and the puddle picture: similar single layer predictions.

Experimental suggestion:

- Giaever transformer bilayer geometry may qualitatively distinguish:
Large drag for vortices, small drag for electrons.